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Thermal Imaging of Thermoelectric 1D nanowires of Bi₂Te₃ using Scanning Thermal Microscopy



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ntroduction: Energy harvesting is certainly one of the most exciting challenge in modern physics. Theoretical calculations, material engineering and novel experimental characterization techniques have risen to fully explore the nanoscale limit and new materials with tailored properties. The purpose of this work is to present the current state-of-progress of the thermal metrology plateform developed at LEMTA and more specifically the scanning thermal microscope (SThM).

We applied this SThM technique to the study of thermoelectric-based Bi_2Te_3 nanowires.

Scanning Thermal Microscopy principle



Principle

The nano-probe can be seen as an **electrical resistance** inside a Wheatstone bridge. When a current I is send, **Joule effect** takes place and heats up the nano-probe.

The knowledge in the variations of current send in the probe are related to its temperature changes and thus to the heat transferred to the nano-objects.

Temperature imaging mode

Inside the SThM



Probe is kept at a constant temperature by keeping V_{Bridge} = constant inside a feedback loop.

The changes in the current are monitored to create an image

DC Conductivity imaging mode and 3- ω SThM

DC probe current is kept constant and the changes across the bridge are monitored to create an image. 3ω-SThM relies on the same principle except that the probe current is a AC-current. The third harmonic of

Thermoresistive Probe



G. Wielgoszewski et al, Sensors and Actuators A: Physical 214 (2014)



the voltage, filtered by a lock-in amplifier, is proportional to the probe temperature: $V(3\omega) \sim T(2\omega)$



